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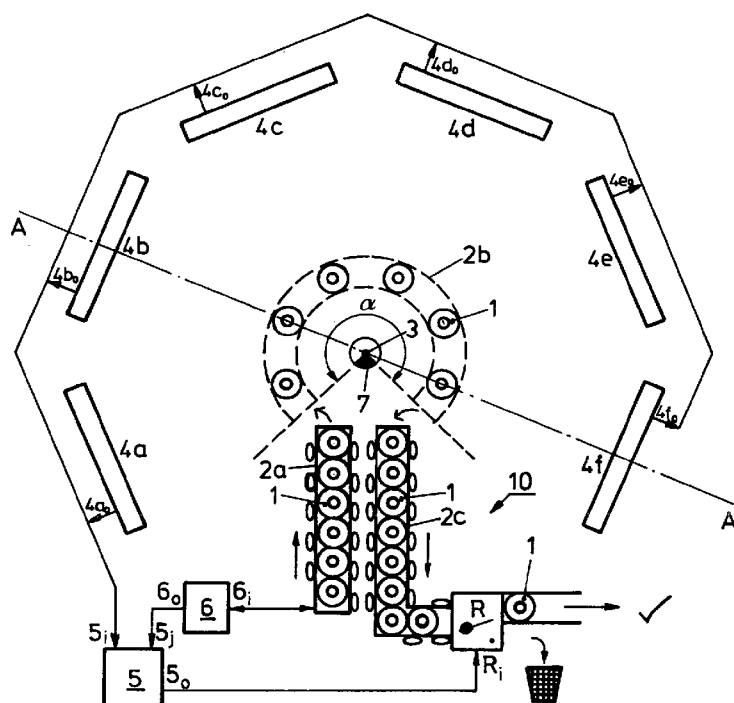
(54) **Title:** X-RAY DETECTION OF FLAWS IN CONTAINERS AND/OR IN THEIR CONTENTS

FIG. 2

(57) **Abstract:** Method and system for x-ray detection of flaws in containers (1) or their contents wherein containers are conveyed on a circular path (2b) around a central axis (3) upon which an x-ray source (7) is situated below the plane (11) of the base of the containers. The x-ray source (7) emits x-ray radiation obliquely upwards through the containers (1) to a plurality of imaging x-ray detectors (4a-f). Analysis of the images provided by these x-ray detectors (4a-f) determines the presence of a flaw in a container or its contents and is used to command a rejection mechanism (R) to reject the container in question.



Declarations under Rule 4.17:

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